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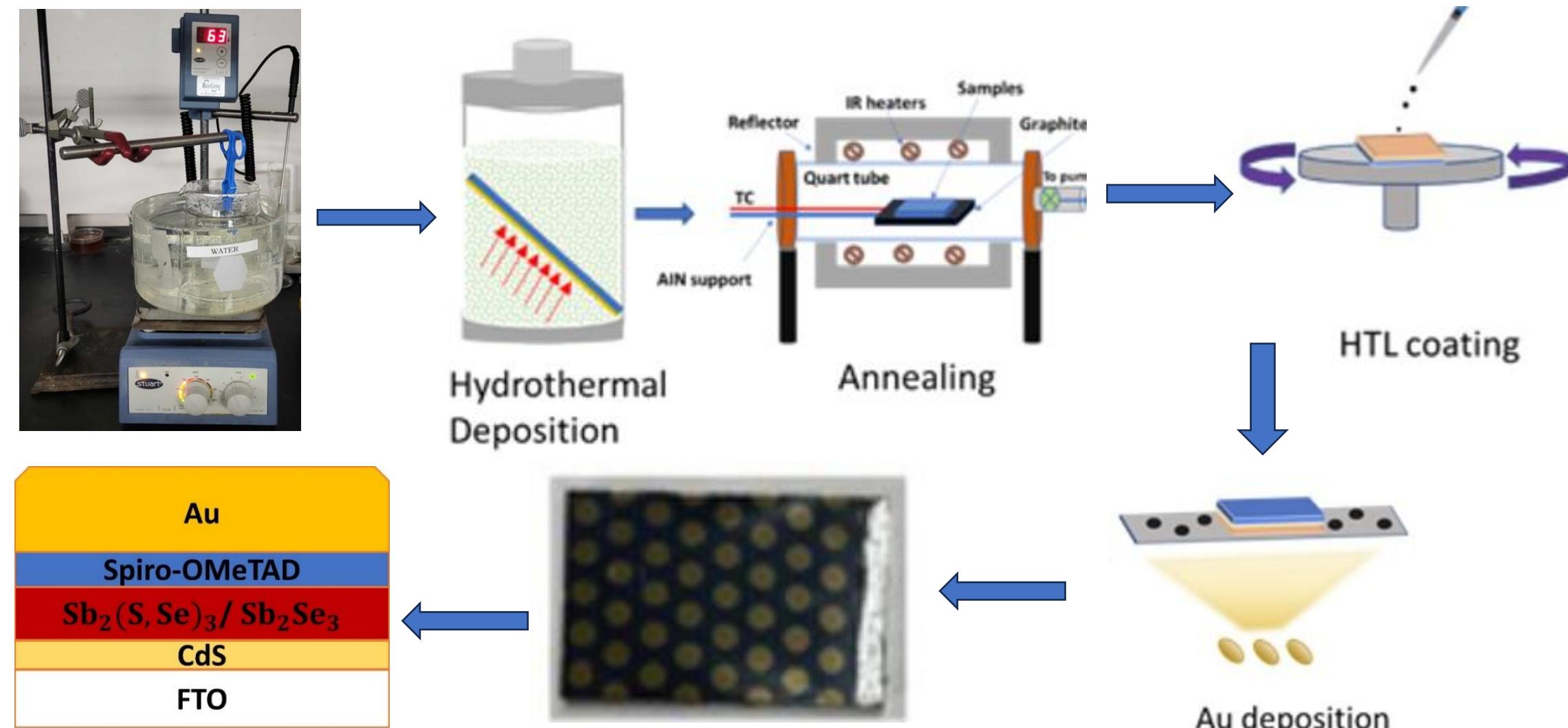
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## Background

- To utilize solar cells for space power applications, studying their proton radiation hardness is pivotal.
- Antimony chalcogenide-based thin-film solar cells have received immense attention for terrestrial and space photovoltaic (PV) applications due to their low cost, ease of synthesis, and material robustness.
- This study aims to understand the effect of proton irradiation on the PV performance of antimony chalcogenide-based solar cells fabricated via hydrothermal method.

## Experimental Details

### Device stacks and fabrication methods



## Takeaways

- Antimony selenide ( $\text{Sb}_2\text{Se}_3$ ) solar cells exhibited high remaining factors in PV performance after being exposed to lower fluences of protons and showed a decreased performance with increasing fluences.
- Antimony sulfoselenide ( $\text{Sb}_2(\text{S},\text{Se})_3$ ) solar cells suffered from significantly reduced device performance after proton irradiation, regardless of fluences and proton energies. This result suggests that sulfur anions are susceptible to proton radiation, causing overall degradation in the device performance of  $\text{Sb}_2(\text{S},\text{Se})_3$  solar cells.

## Results and Discussions

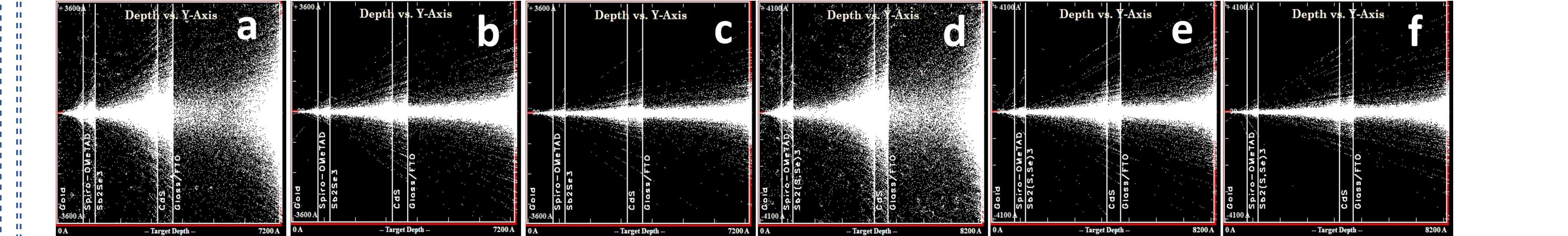


Fig 1: Damage profile in antimony chalcogenide solar cells simulated from SRIM;  $\text{Sb}_2\text{Se}_3$  exposed to (a) 150, (b) 650, and (c) 1000 keV;  $\text{Sb}_2(\text{S},\text{Se})_3$  exposed to (d) 150, (e) 650, and (f) 1000 keV

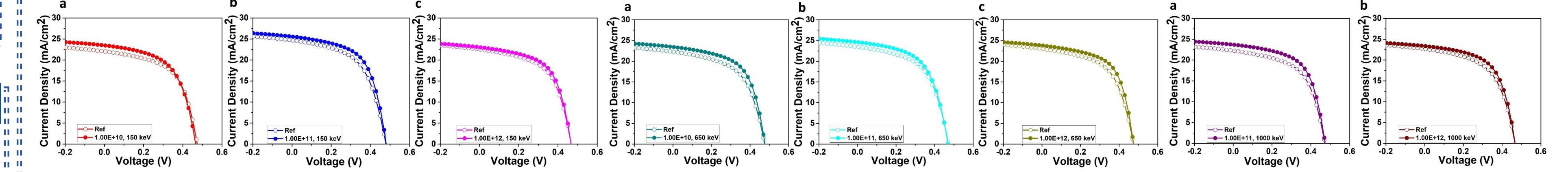


Fig 2: JV curves of champion  $\text{Sb}_2\text{Se}_3$  devices exposed to 150 keV

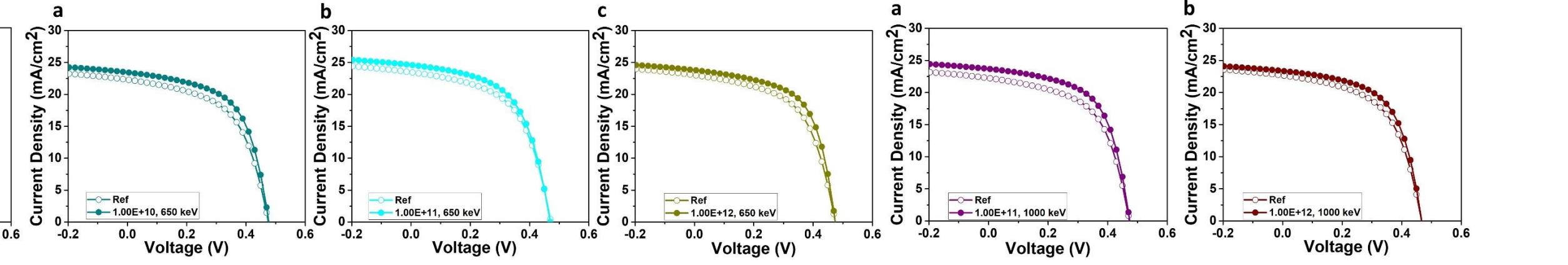


Fig 3: JV curves of champion  $\text{Sb}_2\text{Se}_3$  devices exposed to 650 keV

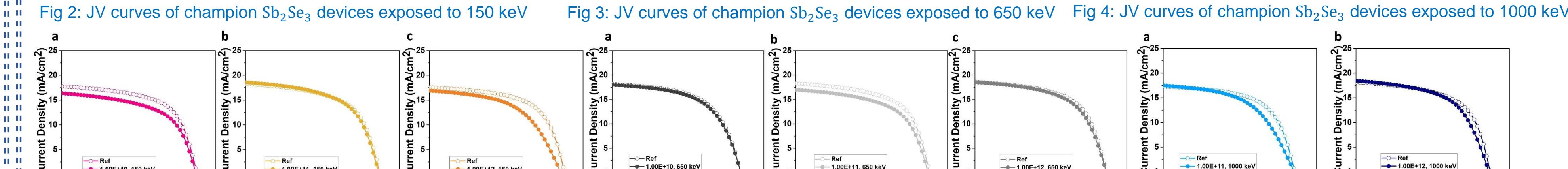


Fig 4: JV curves of champion  $\text{Sb}_2\text{Se}_3$  devices exposed to 1000 keV

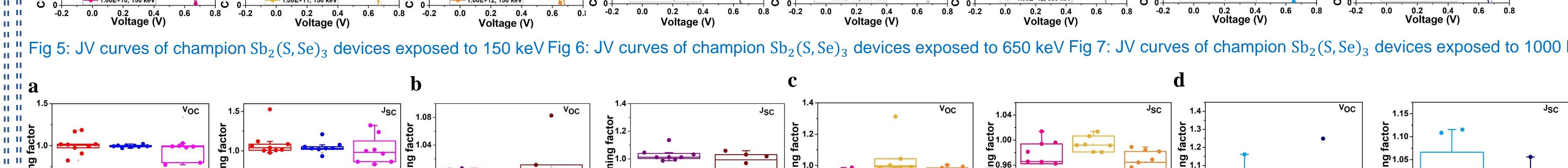


Fig 5: JV curves of champion  $\text{Sb}_2(\text{S},\text{Se})_3$  devices exposed to 150 keV

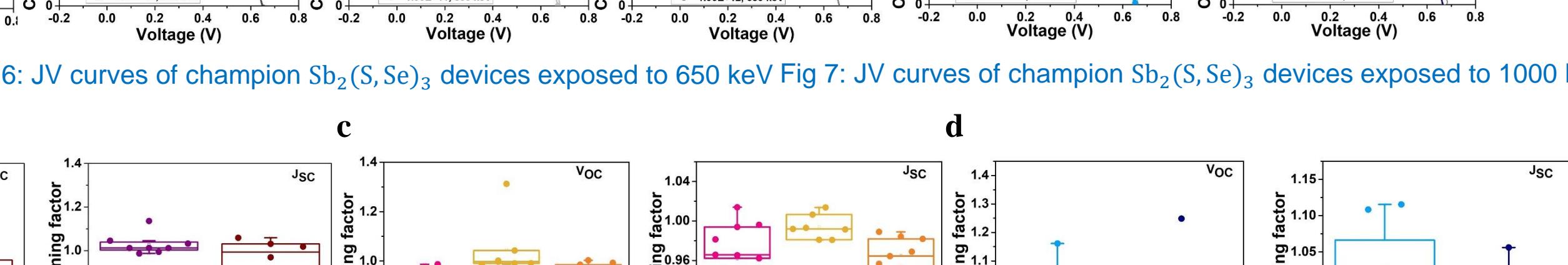


Fig 6: JV curves of champion  $\text{Sb}_2(\text{S},\text{Se})_3$  devices exposed to 650 keV

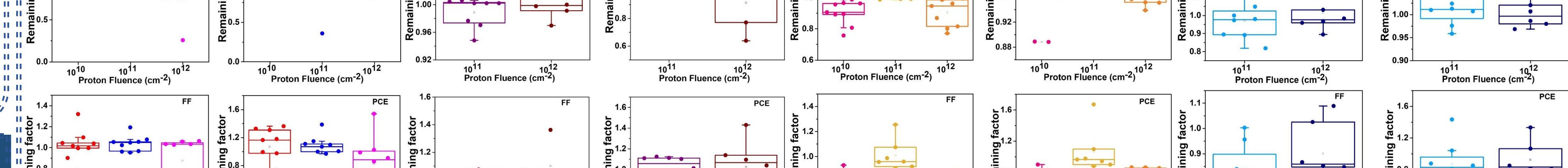


Fig 7: JV curves of champion  $\text{Sb}_2(\text{S},\text{Se})_3$  devices exposed to 1000 keV

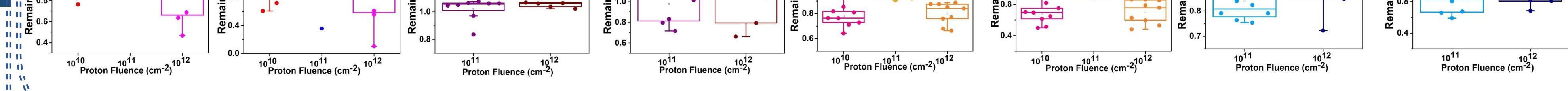


Fig 8: Remaining factor of  $\text{Sb}_2\text{Se}_3$  devices exposed to (a) 150 keV and (b) 1000 keV;  $\text{Sb}_2(\text{S},\text{Se})_3$  devices exposed to (c) 150 keV and (d) 1000 keV

## Acknowledgments

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## Reference

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